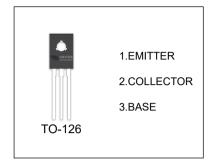


**TIP122** Darlington Transistor (NPN) **TIP127** Darlington Transistor (PNP)

### **FEATURES**

• Medium Power Complementary Silicon Transistors



### **ORDERING INFORMATION**

Part Number	Package	Packing Method	Pack Quantity
TIP122	TO-126	Bulk	200pcs/Bag
TIP127	TO-126	Bulk	200pcs/Bag
TIP122-TU	TO-126	Tube	60pcs/Tube
TIP127-TU	TO-126	Tube	60pcs/Tube

## MAXIMUM RATINGS (Ta=25°C unless otherwise noted)

Symbol	Parameter	TIP122	TIP127	Unit
V <sub>CBO</sub>	Collector-Base Voltage	100	-100	V
V <sub>CEO</sub>	Collector-Emitter Voltage	100	-100	V
V <sub>EBO</sub>	Emitter-Base Voltage	5	-5	V
Ic	Collector Current -Continuous	5	-5	А
P <sub>C</sub> *	Collector Power Dissipation	1.25		W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	100		°C/W
R <sub>θJc</sub>	Thermal Resistance Junction to Case	8.33		.C\M
$T_J, T_{stg}$	Operation Junction and Storage Temperature Range	-55~+150		℃



## 

			TIP12		22 NPN	
Parameter	Symbol	Test conditions	Min	Max	Unit	
Collector-base breakdown voltage	V(BR)CBO	$I_C=1$ mA, $I_E=0$	100		V	
Collector-emitter breakdown voltage	V <sub>CEO</sub> (SUS)	I <sub>C</sub> =30mA,I <sub>B</sub> =0	100		V	
Collector cut-off current	Ісво	V <sub>CB</sub> =100V, I <sub>E</sub> =0		0.2	mA	
Collector cut-off current	I <sub>CEO</sub>	V <sub>CE</sub> =50 V, I <sub>B</sub> =0		0.5	mA	
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> =5 V, I <sub>C</sub> =0		2	mA	
DC current gain	h <sub>FE(1)</sub>	$V_{CE} = 3V, I_{C} = 0.5A$	1000			
	h <sub>FE(2)</sub>	V <sub>CE</sub> = 3V, I <sub>C</sub> =3 A	1000	12000		
Collector emitter acturation valtage	V <sub>CE</sub> (sat)	I <sub>C</sub> =3A,I <sub>B</sub> =12mA		2	V	
Collector-emitter saturation voltage		I <sub>C</sub> =5 A,I <sub>B</sub> =20mA		4		
Base-emitter voltage	V <sub>BE</sub>	V <sub>CE</sub> =3V, I <sub>C</sub> =3 A		2.5	V	
Output Capacitance	Соь	V <sub>CB</sub> =10V, I <sub>E</sub> =0,f=0.1MHz		200	pF	

			TIP127		PNP
Parameter	Symbol	Test conditions	Min	Max	Unit
Collector-base breakdown voltage	V <sub>(BR)CBO</sub>	I <sub>C</sub> =-1mA,I <sub>E</sub> =0	-100		V
Collector-emitter breakdown voltage	V <sub>CEO</sub> (SUS)	I <sub>C</sub> =-30mA,I <sub>B</sub> =0	-100		V
Collector cut-off current	Ісво	V <sub>CB</sub> =-100V, I <sub>E</sub> =0		-0.2	mA
Collector cut-off current	I <sub>CEO</sub>	V <sub>CE</sub> =-50 V, I <sub>B</sub> =0		-0.5	mA
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> =-5 V, I <sub>C</sub> =0		-2	mA
DC current gain	h <sub>FE(1)</sub>	V <sub>CE</sub> =-3V, I <sub>C</sub> =-0.5A	1000		
	h <sub>FE(2)</sub>	V <sub>CE</sub> =-3V, I <sub>C</sub> =-3A	1000	12000	
	V <sub>CE</sub> (sat)	I <sub>C</sub> =-3A,I <sub>B</sub> =-12mA		-2	V
Collector-emitter saturation voltage		I <sub>C</sub> =-5 A,I <sub>B</sub> =-20mA		-4	
Base-emitter voltage	$V_{BE}$	V <sub>CE</sub> =-3V, I <sub>C</sub> =-3 A		-2.5	V
Output Capacitance	Cob	V <sub>CB</sub> =-10V, I <sub>E</sub> =0,f=0.1MHz		300	pF

<sup>\*</sup> This test is performed with no heat sink at  $T_a \! = \! 25^{\circ}\! \text{C}.$ 



# **TIP127**

